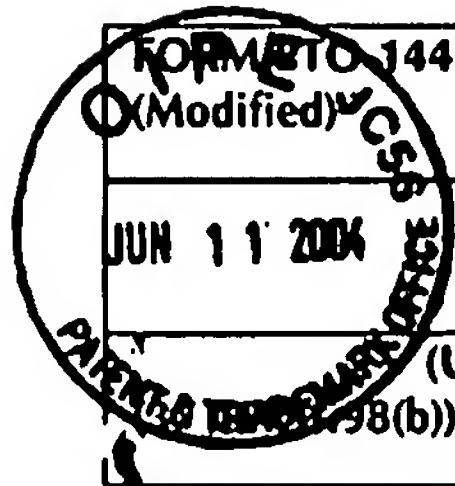


# ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention	OPTIMIZED PLACEMENT OF SUB-RESOLUTION ASSIST FEATURES WITHIN TWO-DIMENSIONAL ENVIRONMENTS						
<p>Application Number : 10/708515</p> <p>Confirmation Number:</p> <p>First Named Applicant: Ronald Gordon</p> <p>Attorney Docket Number: FIS920030380</p> <p>Art Unit: 2624</p> <p>Examiner: David Rashid</p> <p>Search string: ( 5663893 or 5821014 or 6413683 or 6425117 or 6523162 or 6602728 or 20020045106 or 20020192575 or 20030061592 ).pn</p>							
<b>US Patent Documents</b>							
<b>Note: Applicant is not required to submit a paper copy of cited US Patent Documents</b>							
init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
/DPR/	1	5663893	1997-09-02	Wampler et al.			
/DPR/	2	5821014	1998-10-13	Chen et al.			
/DPR/	3	6413683	2002-07-02	Liebmann et al.			
/DPR/	4	6425117	2002-07-23	Pasch et al.			
/DPR/	5	6523162	2003-02-18	Agrawal et al.			
/DPR/	6	6602728	2003-08-05	Leibmann et al.			
<b>US Published Applications</b>							
<b>Note: Applicant is not required to submit a paper copy of cited US Published Applications</b>							
init	Cite.No.	Pub. No.	Date	Applicant	Kind	Class	Subclass
/DPR/	1	20020045106	2002-04-18	Baselmans et al.			
/DPR/	2	20020192575	2002-12-19	Stanton			
/DPR/	3	20030061592	2003-03-27	Agrawal et al.			
<b>Signature</b>							
Examiner Name				Date			
/David Rashid/				04/27/2007			

	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO.: FIS920030380US1	SERIAL NO.: 10/708,515
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT: Gordon et al.	
	(Use several sheets if necessary)		FILING DATE: March 9, 2004	GROUP: <del>2674</del> 2624

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

		U.S. PATENT APPLICATION NO.	FILING DATE	INVENTOR			
/DPR/	AI	S/N 10/338,575	02/28/2003	Liebman et al.			
/DPR/	AJ	S/N 10/378,579	02/28/2003	Gordon et al.			
	AK						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

/DPR/	AQ	"VERIFYING RET MASK LAYOUTS"; J.P. Mayhew, M.L. Rieger, Jiangwei Li, Lin Zhang, Zongwu Tang, J.P. Shiely; Proceedings of the SPIE, March 2002, vol. 4692, pages 336-344, (abstract only).
	AR	
	AS	
EXAMINER	/David Rashid/	DATE CONSIDERED 04/27/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.